

IGBT Chip in NPT-technology

FEATURES:

- 600V NPT technology 100µm chip
- positive temperature coefficient
- easy paralleling
- integrated gate resistor

This chip is used for:

IGBT Modules

G

Applications:

drives

Chip Type	V _{CE}	I _{Cn}	Die Size	Package	Ordering Code
SIGC121T60NR2C	60NR2C 600V 150A 11 x 11 mm ²		sawn on foil	Q67041-A4684-	
319C121100INIX2C	000 v	1304	11 X 11 111111	Sawii Oii ioii	A001

MECHANICAL PARAMETER:

Raster size	11 x 11			
Area total / active	121 / 102.5			
Emitter pad size	8 x 6.2 x 2.55			
Gate pad size	1.51 x 0.8			
Thickness	100	μm		
Wafer size	150	mm		
Flat position	90	grd		
Max.possible chips per wafer	106			
Passivation frontside	Photoimide			
Emitter metallization	3200 nm Al Si 1%			
Collector metallization	1200 nm Ni Ag –system suitable for epoxy and soft solder die bonding			
Die bond	electrically conductive glue or solder			
Wire bond	Al, <500μm			
Reject Ink Dot Size	Ø 0.65mm; max 1.2mm			
Recommended Storage Environment	store in original container, in dry nitr < 6 month at an ambient temperature			



MAXIMUM RATINGS:

Parameter	Symbol	Value	Unit
Collector-emitter voltage, T _j =25 °C	V _{CE}	600	V
DC collector current, limited by T _{jmax}	I _C	1)	Α
Pulsed collector current, t _p limited by T _{jmax}	I _{cpuls}	450	Α
Gate emitter voltage	V _{GE}	±20	V
Operating junction and storage temperature	T_j , T_{stg}	-55 + 150	°C

¹⁾ depending on thermal properties of assembly

STATIC CHARACTERISTICS (tested on chip), $T_{\rm j}$ =25 °C, unless otherwise specified:

Parameter	Symbol Conditions	Value			Unit	
		Conditions	min.	typ.	max.	
Collector-emitter breakdown voltage	V _{(BR)CES}	V_{GE} =0 V , I_{C} =4 mA	600			
Collector-emitter saturation voltage	V _{CE(sat)}	V _{GE} =15V, I _C =150A	1.7	2	2.5	V
Gate-emitter threshold voltage	$V_{\rm GE(th)}$	$I_C=3mA$, $V_{GE}=V_{CE}$	4.5	5.5	6.5	
Zero gate voltage collector current	I _{CES}	V _{CE} =600V, V _{GE} =0V			10.2	μA
Gate-emitter leakage current	I _{GES}	$V_{CE}=0V$, $V_{GE}=20V$			480	nA
Integrated gate resistor	R _{Gint}			5	7	Ω

ELECTRICAL CHARACTERISTICS (tested at component):

Parameter	Symbol Conditions		Value			Unit
raiailietei	Symbol	Conditions	min.	typ.	max.	Oilit
Input capacitance	Ciss	V _{CE} =25V	-	6500		pF
Output capacitance	Coss	V _{GE} =0V	-	tbd		
Reverse transfer capacitance	Crss	f=1MHz	-	600		

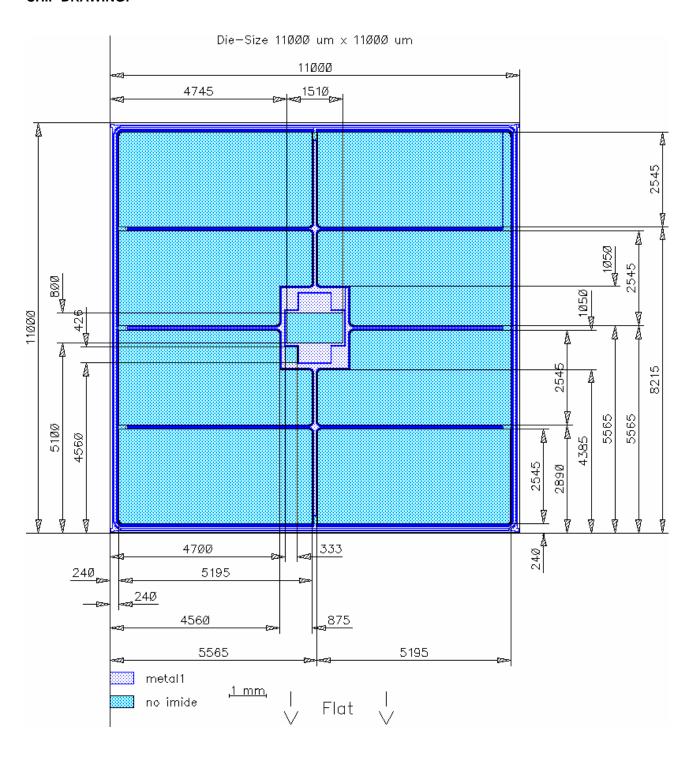
SWITCHING CHARACTERISTICS (tested at component), Inductive Load

Parameter	Symbol Conditions 1)	Conditions 1)	Value			Unit
- arameter	Syllibol	Conditions	min.	typ.	max.	
Turn-on delay time	$t_{d(on)}$	<i>T</i> _j =125°C	-	125		ns
Rise time	t _r	V _{CC} =300V	-	30		
Turn-off delay time	$t_{d(off)}$	I _C =150 A, V _{GE} =-15/15V	-	225		
Fall time	t_{f}	$R_{\rm G}$ =1.5 Ω	-	35		

¹⁾ values also influenced by parasitic L- and C- in measurement and package.



CHIP DRAWING:





FURTHER ELECTRICAL CHARACTERISTICS:

This chip data sheet refers to the device data sheet	BSM 150 GD 60 DLC				
DESCRIPTION:					
AQL 0,65 for visual inspection according to failure catalog					
Electrostatic Discharge Sensitive Device according to MIL-STD 883					
Test-Normen Villach/Prüffeld					

Published by Infineon Technologies AG, Bereich Kommunikation St.-Martin-Strasse 53, D-81541 München © Infineon Technologies AG 2002 All Rights Reserved.

Attention please!

The information herein is given to describe certain components and shall not be considered as warranted characteristics.

Terms of delivery and rights to technical change reserved.

We hereby disclaim any and all warranties, including but not limited to warranties of non-infringement, regarding circuits, descriptions and charts stated herein.

Infineon Technologies is an approved CECC manufacturer.

Information

For further information on technology, delivery terms and conditions and prices please contact your nearest Infineon Technologies Office in Germany or our Infineon Technologies Representatives world-wide (see address list).

Warnings

Due to technical requirements components may contain dangerous substances. For information on the types in question please contact your nearest Infineon Technologies Office.

Infineon Technologies components may only be used in life-support devices or systems with the express written approval of Infineon Technologies, if a failure of such components can reasonably be expected to cause the failure of that life-support device or system, or to affect the safety or effectiveness of that device or system. Life support devices or systems are intended to be implanted in the human body, or to support and / or maintain and sustain and / or protect human life. If they fail, it is reasonable to assume that the health of the user or other persons may be endangered.